

Notice of References Cited	Application/Control No. 10/754,518		Applicant(s)/Patent Under Reexamination HIDAKA ET AL.	
	Examiner Thao X. Le		Art Unit 2814	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,174,222	01-2001	Sato et al.	451/44
	B	US-6,439,969	08-2002	Koma et al.	451/41
	C	US-6,808,784	10-2004	Hashimoto et al.	428/65.3
	D	US-5,490,811	02-1996	Hosokawa, Kaoru	451/239
	E	US-4,905,425	03-1990	Sekigawa et al.	451/41
	F	US-6,544,805	04-2003	Holcman et al.	438/14
	G	US-6,777,820	08-2004	Chiba et al.	257/797
	H	US-6,583,029	06-2003	Abe et al.	438/455
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP2004198264	07-2004	Japan	Yamazaki	H01L021/66
	O	JP02003060013	02-2003	Japan	Fujii	H01L021/68
	P	JP406061201	03-1994	Japan	Ota	H01L021/304
	Q	EP 1150339	10-2001	Europe	Watatani	Ho1L21/02
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.